SPECIFICATION

SPEC. No. A-General-f D A T E: 2017 Aug.

To

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

CGA Series / Automotive grade

General (Up to 50V)

Mid voltage (100 to 630V)

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation

Sales

Electronic Components Sales & Marketing Group Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

This specification warrant the quality of the ceramic chip capacitor. The chips should be evaluated or confirmed a state of mounted on your product.

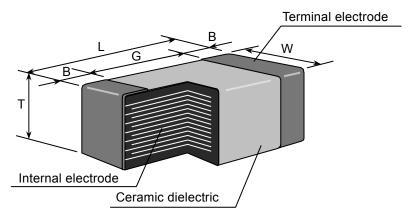
If the use of the chips go beyond the bounds of this specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)

Catalog Number :	CGA4	<u>J</u>	<u>3</u>	<u>X7R</u>	<u>1 C</u>	<u>225</u>	<u>K</u>	<u>125</u>	<u>A</u>	<u>B</u>
(Web)	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)	(10)
Item Description :	CGA4	<u>J</u>	<u>3</u>	<u>X7R</u>	<u>1 C</u>	<u>225</u>	<u>K</u>	<u>T</u>	<u>xxxx</u>	
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(11)	(12)	

(1) Type



^{*}As for dimensions of each product, please refer to detailed information on TDK web.

(2) Thickness

* As for dimension tolerance, please contact with our sales representative.

Thickness	Dimension (mm)
Α	0.30
В	0.50
С	0.60
Е	0.80
F	0.85
Н	1.15
J	1.25
K	1.30
L	1.60
М	2.00
N	2.30
Р	2.50
Q	2.80
R	3.20

(3) Voltage condition in the life test (Max. operating Temp./1000h)

Sign	Condition		
1	Rated Voltage x 1		
2	Rated Voltage x 2		
3	Rated Voltage x 1.5		
4	Rated Voltage x 1.2		

- (4) Temperature Characteristics (Details are shown in table 1 No.7 at page 4 and No.8 at page 5)
- (5) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
1 A	DC 10 V
0 J	DC 6.3 V

(6) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example
$$2R2 \rightarrow 2.2pF$$

 $225 \rightarrow 2,200,000pF$

(7) Capacitance tolerance

Symbol	Tolerance	Capacitance
С	± 0.25 pF	10pE and under
D	± 0.5 pF	10pF and under
J	± 5%	
K	± 10 %	Over 10pF
М	± 20 %	

- (8) Thickness code (Only Catalog Number)
- (9) Package code (Only Catalog Number)
- (10) Special code (Only Catalog Number)
- (11) Packaging (Only Item Description)

(Bulk is not applicable for CGA1 and CGA2 type.)

Symbol	Packaging		
В	Bulk		
Т	Taping		

(12) Internal code (Only Item Description)

3. RATED CAPACITANCE AND TOLERANCE

3.1 Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitar	nce tolerance	Rated capacitance		
	COG X5R X7R X7S X7T	10pF and	C (±0.25pF)	1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5		
		under	D (±0.5pF)	6, 6.8, 7, 8, 9, 10		
1		12pF to 10,000pF	1 (15 0/)	E – 12 series		
		Over 10,000pF	J (±5 %)	E – 6 series		
		10uF and	K (±10 %)			
2		under	M (±20 %)	E – 6 series		
		Over 10uF	M (±20 %)			

3.2 Capacitance Step in E series

E series		Capacitance Step										
E- 6	1.0 1.5				2.2 3.3			4.7		6.8		
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
C0G X7R X7S X7T	-55°C	125°C	25°C

5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as CGA6, CGA8 and CGA9 types are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

8. PERFORMANCE

table 1

No.	Item	Perform	nance	Test or inspection method					
1	External	No defects which m	ay affect	Inspect with magnifying glass (3×), in case					
	Appearance	performance.		of CGA1	type, with m	agnifying	glass (10×)		
2	Insulation Resistance	10,000M Ω or 500M (As for the capacito 16V DC and the ite M Ω or 100M Ω ·μF n smaller.	rs of rated voltage m below, 10,000		rated voltage for 60s. the rated voltage 630V DC, apply				
3	Voltage Proof	Withstand test volta insulation breakdow damage.	•	Class Rated Apply voltage(RV)			voltage		
					RV≦100V		ited voltage		
				1	100V <rv≦50< td=""><td></td><td>ated voltage</td></rv≦50<>		ated voltage		
					500V <rv< td=""><td></td><td>ated voltage</td></rv<>		ated voltage		
					RV≦100V	2.5 × r	ated voltage		
				2	100V <rv≦50< td=""><td></td><td>ated voltage</td></rv≦50<>		ated voltage		
					500V <rv< td=""><td>1.3 × r</td><td>ated voltage</td></rv<>	1.3 × r	ated voltage		
				Above DC voltage shall be applie Charge / discharge current shall exceed 50mA.			lied for 1s.		
4	Capacitance	Within the specified	I tolerance.	Class	Capacitance	Measuring frequency	Measuring voltage		
			Class1	1000pF and under	1MHz±10%	,			
				Over 1000pF	1kHz±10%	0.5-5 Vms.			
				10uF and under	1kHz±10%	1.0±0.2Vms 0.5±0.2Vms.			
						120Hz±20%	0.5±0.2Vms.		
5	Q (01===4)	Capacitance	Q		4 in this table	for meas	uring		
	(Class1)			conditio	condition.				
		30pF and over	1,000 min.						
		Under 30pF 400+20×C min.							
		C : Rated capacitar	nce (pF)						
6	Dissipation Factor (Class2)	0.025 max. 0.03 max. 0.05 max. 0.075 max. 0.1 max.	See No.4 in this table for measuring condition. For information which product has which dissipation factor, please see the detail page of each product on website.						
7	Temperature Characteristics of Capacitance	T.C. Tempera	ature Coefficient	Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature. Measuring temperature below 20°C shall be -10°C and -25°C.					
	(Class1)	C0G 0 ± 3	30 (ppm/°C)						
		Capacitance drift with ± 0.05pF, whicheve							

No.	Item	Performance	Test or inspection method			
8	Temperature Characteristics	Capacitance Change (%)	Capacitance shall be measured by the steps shown in the following table after			
	of Capacitance (Class2)	No voltage applied	thermal equilibrium is obtained for each step.			
		X5R : ± 15 X7R : ± 15	ΔC be calculated ref. STEP3 reading			
		X7R:±15 X7S:±22	Step Temperature(°C)			
		X7T: +22, -33	1 Reference temp. ± 2			
			2 Min. operating temp. ± 3			
			3 Reference temp. ± 2			
			4 Max. operating temp. ± 2			
			Measuring voltage: 0.1, 0.2, 0.5, 1.0Vrms. For information which product has which Measuring voltage, please contact with our sales representative.			
9	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing force of 17.7N with 10±1s. (2N is applied for CGA1, CGA2 type) Pushing force P.C.Board			
10	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2a or Appendix 2b and bend it for 2mm. (1mm is applied for 0.85mm thickness of Class2 items.)			

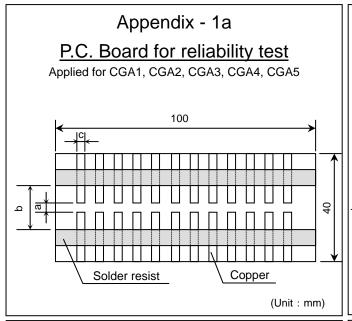
No.	1 Solderability		Performance New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material. A section			Test or inspection method	
11						Solder: Sn-3.0Ag-0.5Cu or Sn-37Pb Temperature:245±5°C(Sn-3.0Ag-0.5Cu) 235±5°C(Sn-37Pb) Soaking time:3±0.3s(Sn-3.0Ag-0.5Cu) 2±0.2s(Sn-37Pb) Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
12	Resistance to solder heat	External appearance Capacitance	No cracks are allowed and terminations shall be covered at least 60% with new solder.			Completely soak both terminations in solder at the following conditions. 260±5°C for 10±1s.	
				eristics	Change from the value before test Capacitance drift	Preheating condition Temp.: 110 to 140°C	
			Class1	C0G	within ± 2.5% or ± 0.25pF, whichever larger.	Time : 30 to 60s.	
			Class2	X5R X7R X7S	± 7.5 %	Solder: Sn-3.0Ag-0.5Cu or Sn-37Pb	
		Q (Class1)	Meet the	Meet the initial spec. Meet the initial spec.		Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
		D.F. (Class2)	Meet the			Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h	
		Insulation Resistance	Meet the	initial	spec.	(Class2) before measurement.	
		Voltage proof	No insula other dar		eakdown or	-	

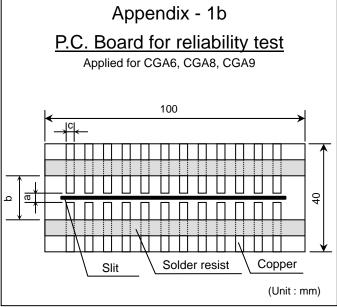
No.	Ite	em	Performance				Test or inspection method				
13	Vibration	External appearance	No mechanical damage.			P.C.Bo	Reflow solder the capacitors on a P.C.Board shown in Appendix1 before testing.				
		Capacitance	Charact	eristics	value before test	Vibrate	e the capacitor with fol	lowing			
			Class1	COG	Capacitance drift within ± 2.5% or ± 0.25pF, whichever larger.	Applie	d force : 5G max. ency : 10-2000Hz				
			Class2	X5R X7R X7S X7T	± 7.5 %	Duration: 20 min. Cycle: 12 cycles in each 3 mutually perpendicular directions.		ually			
		Q (Class1)	Meet the	initial	spec.						
		D.F. (Class2)	Meet the initial spec.								
14	Temperature cycle	External appearance	No mechanical damage.			P.C.Bo	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.				
		Capacitance	Charact	eristics	Change from the value before test	step1	Expose the capacitors in the step1 through step 4 and repo				
						Class1	COG X5R	Capacitance drift within ± 2.5% or ± 0.25pF, whichever larger.	Leave condit	consecutively. the capacitors in amb ion for 6 to 24h (Class (Class 2) before meas	1) or
			Class2	VZD	Step	Temperature(°C)	Time (min.)				
		Q	Meet the	initial	spec.	1	Min. operating temp. ±3	30 ± 3			
		(Class1)				2	Reference Temp. ±2	2 - 5			
		D.F. (Class2)	Meet the	Meet the initial spec.		3	Max. operating temp. ±2	30 ± 2			
		Insulation Resistance	Meet the	initial	spec.	4	Reference Temp. ±2	2 - 5			
		Voltage proof	No insula other da		reakdown or						

lo.			Performance			Test or inspection method					
15	Moisture Resistance	No mechanical damage.			Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or						
	(Steady State)	Capacitance	Charact	eristics	Change from the value before test	Appendix 1b before testing.					
			Class1	COG	Capacitance drift within ± 5% or ± 0.5pF, whichever larger.	Leave at temperature 40±2°C, 90 to 95%RH for 500 +24,0h.					
			Class2	X5R X7R X7S X7T	± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.					
		Q (Class1)	Capac	itance	Q						
		(Class1)	30pFar	nd over	350 min.						
			10pF ar under		275+5/2×C min.						
			Under	10pF	200+10×C min.						
			C : Rate	d capa	citance (pF)						
		D.F. (Class2)	Characteristics 200% of initial spec. max.								
		Insulation	1,000M Ω or 50M Ω ·μF min.								
		Resistance	(As for the capacitors of rated voltage 16V DC and item below, 1,000M Ω or 10M Ω · μ F min.,) whichever smaller.								
16	Moisture Resistance	External appearance	No mech	anical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or					
	rtoolotanoo	Capacitance		eristics	Change from the	Appendix 1b before testing. Apply the rated voltage at temperatur					
										value before test Capacitance drift within ± 7.5% or	85°C and 85%RH for 1000 +24,0h.
			Class2	X5R X7R X7S X7T	± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.					
		Q (Class1)	Capac	itance	Q	Voltage conditioning (only for class 2) Voltage treat the capacitors under					
		(0.0001)	30pF ar	nd over	200 and over	testing temperature and voltage for 1					
			Under 30pF 100+10/3×C min.		100+10/3×C min.	hour. Leave the capacitors in ambient					
					citance (pF)	condition for 24±2h before measurement. Use this measurement for initial value					
		D.F. (Class2)	Characte 200% of		spec. max.						
		Insulation Resistance	(As for th voltage 1	e capa 6V DC 00MΩ (Ω·μF min. acitors of rated and item or 5MΩ·μF min.,) ller.						

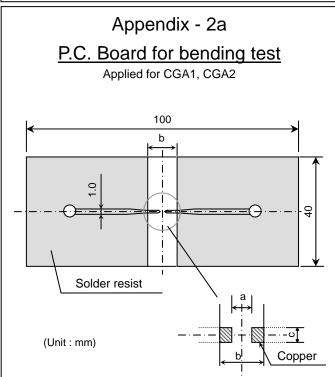
No.	Item		Performance		rmance	Test or inspection method	
17	Life	External appearance	No mech	anical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.	
		Capacitance	Charact	eristics	Change from the value before test	Below the voltage shall be applied at	
			Class1	C0G	Capacitance drift within ± 3% or ± 0.3pF,	maximum operating temperature ±2°C for 1,000 +48, 0h.	
				\/FD	whichever larger.	Applied voltage	
			Class?	X5R X7R	± 15 %	Rated voltage x2	
			Class2	X7S X7T	± 15 /6	Rated voltage x1.5	
						Rated voltage x1.2	
		Q (Class1)	Capa	citance	Q	Rated voltage x1	
			30pF and over 10pF and over under 30pF		350 and over	For information which product has which	
					o 275+5/2×C min.	applied voltage, please contact with our sales representative.	
			Unde	r 10pF	200+10×C min.	· ·	
			C : Rated capacitance (pF)			Charge/discharge current shall not	
		D.F. (Class2)	Characteristics 200% of initial spec. max.			exceed 50mA.	
		Insulation Resistance	1,000MΩ or 50MΩ·μF min. (As for the capacitors of rated voltage 16V DC and the item below, 1,000 MΩ or 10MΩ·μF min.,) whichever smaller.		acitors of rated C and the item Ω or 10MΩ·μF	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.	
						Voltage conditioning (only for class 2) Voltage treat the capacitors under testing temperature and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	

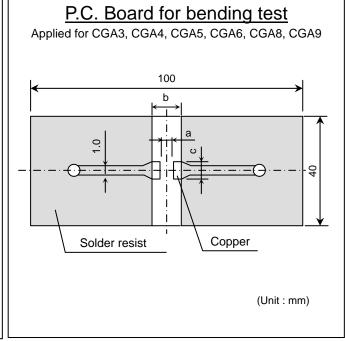
^{*}As for the initial measurement of capacitors (Class2) on number 8,12,13,14 and 15 leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





Appendix - 2b





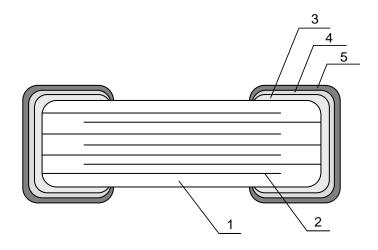
P.C. Board thickness : Appendix-2a 0.8mm
Appendix-1a, 1b, 2b 1.6mm

Copper (thickness 0.035mm)
Solder resist

Material: Glass Epoxy (As per JIS C6484 GE4)

TDK (EIA style)	Dimensions (mm)				
TDK (EIA Style)	а	b	С		
CGA1(CC0201)	0.3	0.8	0.3		
CGA2(CC0402)	0.4	1.5	0.5		
CGA3(CC0603)	1.0	3.0	1.2		
CGA4(CC0805)	1.2	4.0	1.65		
CGA5(CC1206)	2.2	5.0	2.0		
CGA6(CC1210)	2.2	5.0	2.9		
CGA8(CC1812)	3.5	7.0	3.7		
CGA9(CC2220)	4.5	8.0	5.6		

9. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATERIAL				
No.	INAIVIE	Class1	Class2			
1	Dielectric	CaZrO₃	BaTiO ₃			
2	Electrode	Nickel (Ni)				
3		Copper (Cu)				
4	Termination	Nickel (Ni)				
5		Tin (Sn)				

10. RECOMMENDATION

As for CGA6(CC1210), CGA8(CC1812) and CGA9(CC2220) types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for CGA1(CC0201), CGA2(CC0402), CGA6(CC1210) , CGA8(CC1812) and CGA9(CC2220) types, reflow soldering only.

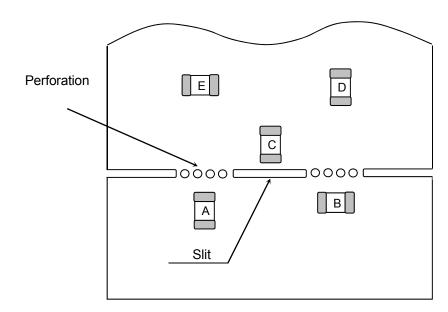
12. CAUTION

Process	Condition					
Operating Condition (Storage,	 1-1. Storage 1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt. 					
Transportation)	 The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. 					
	3) Avoid storing in sun light and falling of dew.					
	4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.					
	5) Capacitors should be tested for the solderability when they are stored for long time.					
	1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the					
	capacitors may be deteriorated depending on the transportation condition.					
Circuit decign	(Refer to JEITA RCR-2335C 9.2 Handling in transportation) 2-1. Operating temperature					
Circuit design	Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.					
	Do not use capacitors above the maximum allowable operating temperature.					
	Surface temperature including self heating should be below maximum operating temperature.					
	(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor					
	surface shall be below 20°C)					
	3) The electrical characteristics of the capacitors will vary depending on th temperature. The capacitors should be selected and designed in taking th temperature into consideration.					
	 2-2 Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. 					
	AC or pulse with overshooting, V _{P-P} must be below the rated voltage. (1) and (2) AC or pulse with overshooting, V _{P-P} must be below the rated voltage. (3), (4) and (5)					
	When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.					
	Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
	Positional Measurement (Rated voltage) 0					
	Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
	Positional Measurement (Rated voltage)					
	Operating Condition (Storage, Transportation)					

No.	Process			Condition	on				
2	Circuit design	2) Even below the	rated voltage	e, if repetitive	high freque	ncy AC or pul	se is applied,		
	∠!\ Caution	the reliability of	the reliability of the capacitors may be reduced.						
		3) The effective ca	3) The effective capacitance will vary depending on applied DC and AC voltages.						
		•	The capacitors should be selected and designed in taking the voltages into						
		consideration.							
		2-3. Frequency	oitoro (Class	2) are used	in AC and/or	nulaa valtaa	oo tho		
		When the capa capacitors may	,	*			55, III C		
	5	-							
3	Designing P.C. board	The amount of sold capacitors.	ler at the teri	minations ha	is a direct ef	tect on the re	eliability of the		
		1) The greater the	amount of so	older, the hig	her the stres	s on the chip	capacitor, and		
		the more likely		_		•	-		
		shape and size terminations.	of the solder	lands to hav	e proper am	ount of solder	on the		
		Avoid using cor	mmon solder	land for mult	inle terminati	ons and prov	ide individual		
		solder land for			ipic terriiriati	ono ana prov	iac inaiviadai		
		3) Size and recom	nmended land	d dimensions					
				Chip capacito	or.				
		_		/	" Solder la <i>I</i>	nd			
		Solder resist							
		· Flow solde	erina			(mm)			
		Type	CGA3	CGA	4 C	GA5			
		Symbol	(CC0603)	(CC080		1206)			
		A	0.7 - 1.0	1.0 - 1		- 2.5			
		B C	0.8 - 1.0 0.6 - 0.8	1.0 - 1 0.8 - 1		- 1.3 - 1.3			
			0.0 - 0.0	0.6 - 1	.1 1.0	- 1.3			
		· Reflow sol	· •	0040	0040	1 0044	(mm)		
		Type Symbol	CGA1 (CC0201)	CGA2 (CC0402)	CGA3 (CC0603)	CGA4 (CC0805)			
		A	0.25 - 0.35	0.3 - 0.5	0.6 - 0.8	0.9 - 1.2			
		B	0.2 - 0.3	0.35 - 0.45	0.6 - 0.8	0.7 - 0.9	<u>.</u>		
		C	0.25 - 0.35	0.4 - 0.6	0.6 - 0.8	0.9 - 1.2			
		Type Symbol	CGA5 (CC1206)	CGA6 (CC1210)	CGA8 (CC1812)	CGA9 (CC2220)			
		A	2.0 - 2.4	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8	-		
		В	1.0 - 1.2	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4	•		
		С	1.1 - 1.6	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0	-		
							•		

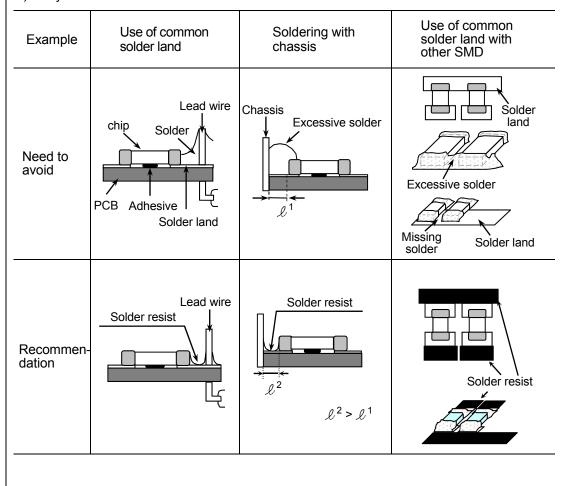
No.	Process			Condition	
3	Designing P.C.board	4)	Recommende	ed chip capacitor layout is as follo	wing.
				Disadvantage against bending stress	Advantage against bending stress
				Perforation or slit	Perforation or slit
			Mounting face		
				Break P.C.board with mounted side up.	Break P.C.board with mounted side down.
				Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
			Chip	Perforation or slit	Perforation or slit
			arrangement (Direction)		
				Closer to slit is higher stress	Away from slit is less stress
			Distance from slit	$\begin{array}{c c} & \ell_1 \\ \hline & \vdots \\ & \ell_2 \end{array}$	$\begin{array}{c c} & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & \\ & & & \\ & &$
				(21 - 22)	(~1 -~2)

No. Process Condition 3 Designing P.C.board 5) Mechanical stress varies according to location of chip capacitors on the P.C.board.



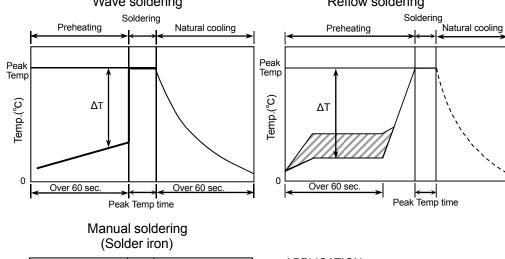
The stress in capacitors is in the following order. A > B = C > D > E

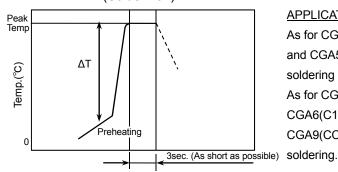
6) Layout recommendation



No.	Process			Condition				
4	Mounting	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitor to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 2) Adjust the mounting head pressure to be 1 to 3N of static weight. 3) To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. 						
		See following		commended	Recommended			
		Single sided mounting	1101101	Crack	Support pin			
		Double-si des mounting	Solder peeling	Crack	Support pin			
		When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.						
		4-2. Amount of ad	hesive	a a a a				
				ccc				
			Example :	CGA4 (CC0805), C	GA5 (CC1206)			
			а	0.2mm ı	min.			
			b	70 - 100	<u>·</u>			
			С	Do not touch the	e solder land			

No.	Process	Condition					
5	Soldering	 5-1. Flux selection Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitors. To avoid such degradation, it is recommended following. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 2) Excessive flux must be avoided. Please provide proper amount of flux. 3) When water-soluble flux is used, enough washing is necessary. 					
	5-2. Recommended soldering profile by various methods						
	Wave soldering Reflow soldering						





APPLICATION

As for CGA3(CC0603), CGA4(CC0805) and CGA5(CC1206), applied to wave soldering and reflow soldering. As for CGA1(CC0201), CGA2(CC0402), CGA6(C1210), CGA8(CC1812), CGA9(CC2220) applied only to reflow

*As for peak temperature of manual soldering, please refer"5-6. Solder repair by solder iron"

5-3. Recommended soldering peak temp and peak temp duration

	Wave soldering Reflow Peak temp(°C) Duration(sec.) Peak temp(°C)		Reflow soldering		
			Duration(sec.)		
Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.	
Lead Free Solder	260 max.	5 max.	260 max.	10 max.	

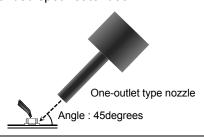
Recommended solder compositions Sn-37Pb (Sn-Pb solder) Sn-3.0Ag-0.5Cu (Lead Free Solder)

No.	Process	Condition				
5	Soldering	5-4. Avoiding thermal shock				
		1) Preheating condition				
		Soldering	Туре	Temp. (°C)		
		Wave soldering	CGA3(CC0603), CGA4(CC08 CGA5(CC1206)	Δ1 ≤150		
		Reflow soldering	CGA1(CC0201), CGA2(CC04 CGA3(CC0603), CGA4(CC08 CGA5(CC1206)	ΔT ≤150		
			CGA6(CC1210), CGA8(CC18 CCGA9(CC2220)	Δ1 ≤130		
		Manual soldering	CGA1(CC0201), CGA2(CC04 CGA3(CC0603), CGA4(CC08 CGA5(CC1206)	ΔT ≤150		
			CGA6(CC1210), CGA8(CC18 CGA9(CC2220)	ΔT ≤130		
		5-5. Amount of solder Excessive solder will induce	is recommended. If the chips are difference (ΔT) must be less the higher tensile force in chip capt in chip cracking. In sufficients.	nan 100°C. pacitors when temperature		
		Excessive solder		ner tensile force in chip acitor to cause crack		
		Adequate	Maximum			
		Insufficient solder	con	robustness may cause tact failure or chip acitor comes off the board.		
		5-6. Solder repair by solder iro	าท			
		Selection of the soldering Tip temperature of solder is size. The higher the tip ter may cause a crack in the operation of the soldering size. Please make sure the tip to accordance with following.	iron tip iron varies by its type, P.C.board i nperature, the quicker the operati	the peak temp and time in preheat the chip		
		Recommended solder iro	on condition (Sn-Pb Solder and	Lead Free Solder)		
			Temp. (°C) Wattage (W)	Shape (mm)		
		CGA1(CC0201) CGA2(CC0402) CGA3(CC0603) CGA4(CC0805) CGA5(CC1206)	350 max. 20 max.	ϕ 3.0 max.		
		CGA6(CC1210) CGA8(CC1812) CGA9(CC2220)	280 max.			

Na	Drosses	Condition
No.	Process	Condition
5	Soldering	 Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.
		3) It is not recommended to reuse dismounted capacitors. (For soft electrode)
		5-7. Soldering rework using spot heater Heat stress during rework may possibly be reduced by using a spot heater (also called a "blower") rather than a soldering iron. It is applied only to adding solder in the case of insufficient solder amount.
		1) Reworking using a spot heater may suppress the occurrence of cracks in the capacitor compared to using a soldering iron. A spot heater can heat up a capacitor uniformly with a small heat gradient which leads to lower thermal stress caused by quick heating and cooling or localized heating. Moreover, where ultra-small capacitors are mounted close together on a printed circu board, reworking with a spot heater can eliminate the risk of direct contact between the tip of a soldering iron and a capacitor.
		2) Rework condition If the blower nozzle of a spot heater is too close to a capacitor. a crack in the capacit may occur due to heat stress. Below are recommendations for avoiding such an occurrence. Keep more than 5mm between a capacitor and a spot heater nozzle. The blower temperature of the spot theater shall be lower than 400°C. The airflow shall be set as weak as possible. The diameter of the nozzle is recommended to be 2mm(one-outlet type). The size is standard and common. Duration of blowing hot air is recommended to be 10s or less CGA3(CC0603), CGA4(CC0805), CGA5(CC1206) and 30s or less for CGA6(CC1210), CGA8(CC1812) and CGA9(CC2220), considering surface area of the capacitor and melting temperature of solder. The angle between the nozzle and the capacitor is recommended to be 45degrees i order to work easily and to avoid partial area heating. As is the case when using a soldering iron, preheating reduces thermal stress on capacitors and improves operating efficiency.
		• Recommended rework condition (Consult the component manufactures for details.)
		Distance from nozzle 5mm and over
		Nozzle angle 45degrees
	i e	

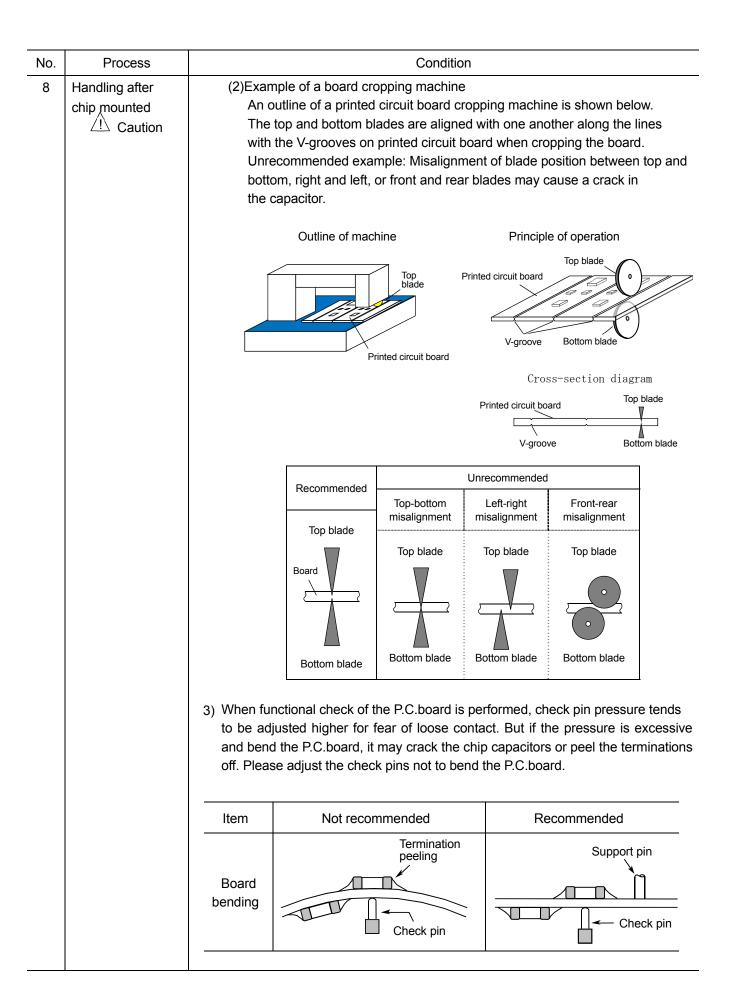
Recommended rework condition (Consult the component mandiactures for details.)				
Distance from nozzle	5mm and over			
Nozzle angle	45degrees			
Nozzle temp. 400°C and less				
Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the Conditions mentioned above.)			
Nozzle diameter	ϕ 2mm (one-outlet type)			
Blowing duration	10s and less (CGA3[CC0603], CGA4[CC0805], CGA5[CC1206]) 30s and less (CGA6[CC1210], CGA8[CC1812], CGA9[CC2220])			

• Example of recommended spot heater use



No.	Process	Condition
5	Soldering	 Amount of solder should be suitable to from a proper fillet shape. Excess solder causes mechanical and thermal stress on a capacitor and results in cracks. Insufficient solder causes weak adherence of the capacitor to the substrate and may result in detachment of a capacitor and deteriorate reliability of the printed wiring board. See the example of appropriate solder fillet shape for 5-5. Amount of solder. 5-8. Sn-Zn solder
		Sn-Zn solder affects product reliability.
		Please contact TDK in advance when utilize Sn-Zn solder.
		5-9. Countermeasure for tombstone
		The misalignment between the mounted positions of the capacitors and the land
		patterns should be minimized. The tombstone phenomenon may occur especially
		the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering.
		(Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the
		tombstone phenomenon)
6	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing (1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20W/
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.

No.	Process	Condition				
7	Coating and molding of the P.C. board	 When the P.C. board is coated, please verify the quality influence on the product Please verify carefully that there is no harmful decomposing or reaction gasemission during curing which may damage the chip capacitors. Please verify the curing temperature. 				
8	Handling after chip mounted Caution	1) Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack. Bend Twist Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board. (1)Example of a board cropping jig Recommended example: The board should be pushed from the back side, close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks.				
		Outline of jig Printed circuit board Printed circuit board Board cropping jig Recommended Unrecommended Unrecommended Unrecommended Printed circuit board Load point Printed circuit board V-groove Slot Slo				



No.	Process	Condition
9	Handling of loose chip capacitors	1) If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Floor 2) Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. P.C.board Crack
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F(Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
12	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation
13	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the
		applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships, etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment
		(13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly
		requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

13. PACKAGING LABEL

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{7}$ \underline{A} - \underline{OO} - \underline{OOO} (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

14. BULK PACKAGING QUANTITY

Total number of components in a plastic bag for bulk packaging : 1,000pcs. As for CGA1, CGA2 types, not available for bulk packaging.

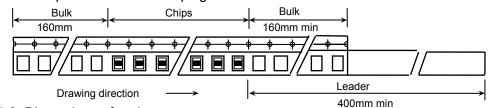
15. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4, 5. Dimensions of plastic tape shall be according to Appendix 6, 7.

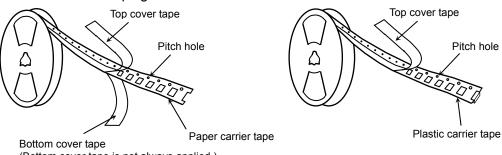
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 8, 9. Dimensions of Ø330 reel shall be according to Appendix 10, 11.

1-4. Structure of taping



(Bottom cover tape is not always applied.)

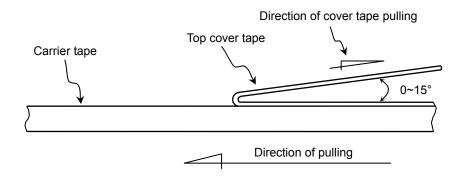
2. CHIP QUANTITY

Typo	Thickness	Taping	Chip quantity(pcs.)		
Type	of chip Material		Ø 178mm reel	Ø 330mm reel	
CGA1(CC0201)	0.30 mm	Paper	15,000	-	
CGA2(CC0402)	0.50 mm	Paper	10,000	50,000	
CGA3(CC0603)	0.80 mm	Paper/ Plastic	4,000	10,000	
	0.60mm	Paper	4,000	20,000	
CGA4(CC0805)	0.85 mm	Paper	4,000	10,000	
	1.25 mm	Plastic	2,000	10,000	
	0.60 mm	Paper	4,000		
	0.85 mm	rapei	4,000	10.000	
CGA5(CC1206)	1.15 mm			10,000	
	1.30 mm	Plastic	2,000		
	1.60 mm			8,000	
	1.25 mm	Plastic	2,000	8,000	
	1.60 mm		2,000	0,000	
CGA6(CC1210)	2.00 mm		1,000	5,000	
	2.30 mm				
	2.50 mm			·	
	1.60 mm		1,000		
	2.00 mm		1,000	2.000	
CGA8(CC1812)	2.30 mm	Plastic		3,000	
CGA6(CC1612)	2.50 mm	Flasiic	500		
	2.80 mm		300	2,000	
	3.20 mm			2,000	
	1.60 mm		1,000		
CGA9(CC2220)	2.00 mm	Plastic	500	3,000	
CGA9(CC2220)	2.30 mm	Plastic			
	2.50 mm				

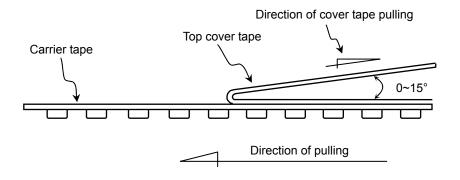
3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05-0.7N. (See the following figure.)

TYPE 1 (Paper)

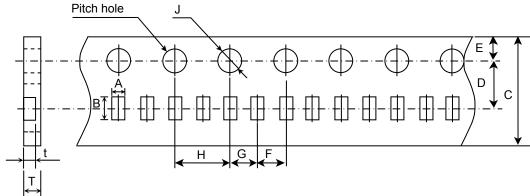


TYPE 2 (Plastic)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

Paper Tape



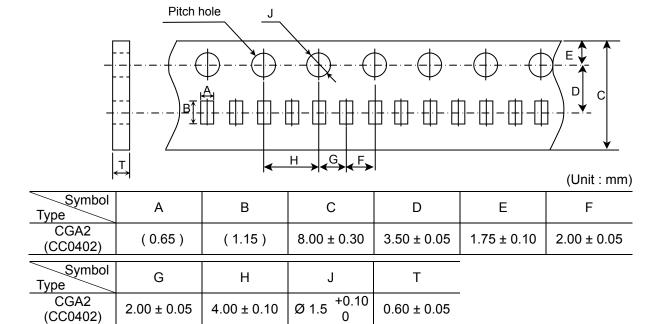
(Unit: mm)

Symbol Type	А	В	С	D	E	F
CGA1 (CC0201)	(0.38)	(0.68)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
•						
Symbol Type	G	Н	J	t	Т	-
CGA1 (CC0201)	2.00 ± 0.05	4.00 ± 0.05	Ø 1.5 ^{+0.10}	0.35 ± 0.02	0.40 min.	

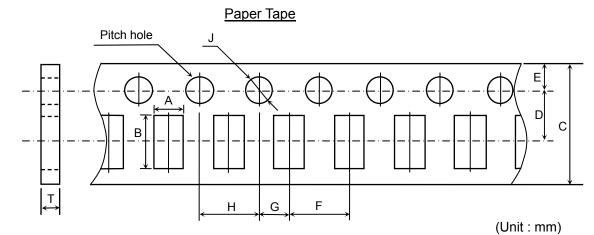
^{*} The values in the parentheses () are for reference.

Appendix 4

Paper Tape



^{*} The values in the parentheses () are for reference

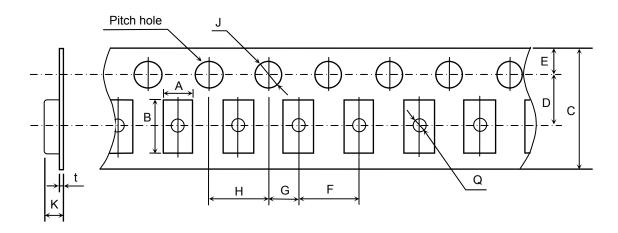


Symbol Type	А	В	С	D	E	F
CGA3 (CC0603)	(1.10)	(1.90)				
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	(1.90)	(3.50)				

Symbol Type	G	Н	J	Т
CGA3 (CC0603) CGA4 (CC0805) CGA5 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 ^{+0.10}	1.20 max.

 $^{^{\}ast}$ The values in the parentheses () are for reference.

Plastic Tape



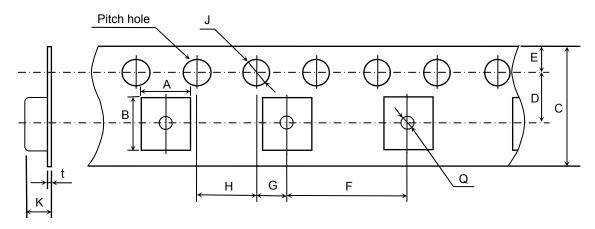
(Unit:mm)

Symbol	А	В	С	D	Е	F
Туре	, ,				_	
CGA3 (CC0603)	(1.10)	(1.90)				
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	(1.90)	(3.50)	[12.0 ± 0.30]	[5.50 ± 0.05]	1.75 ± 0.10	4.00 ± 0.10
CGA6 (CC1210)	(2.90)	(3.60)				
Symbol Type	G	Н	J	К	t	Q
CGA3 (CC0603)				1.50 max.		
CGA4 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	2.50 max.	0.30 max.	Ø 0.50 min.
CGA5 (CC1206)	2.00 £ 0.05	4.00 ± 0.10	0	2.50 IIIax.		0.50 IIIII.
CGA6 (CC1210)				3.20 max.	0.60 max.	

 $^{^{\}ast}$ The values in the parentheses ($\,$) are for reference.

^{*} As for 2.5mm thickness products, apply values in the brackets [].

Plastic Tape

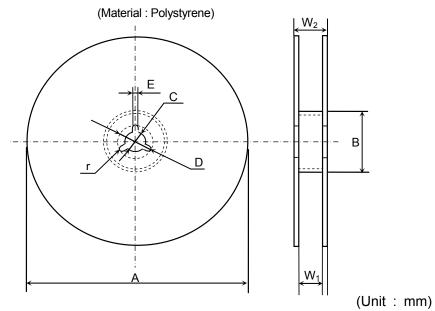


(Unit:mm)

Symbol Type	А	В	С	D	E	F
CGA8 (CC1812)	(3.60)	(4.90)	12.0 ± 0.20	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
CGA9 (CC2220)	(5.40)	(6.10)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	6.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
CGA8 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	Ø 1.50 min.
CGA9 (CC2220)	2.00 ± 0.05	4.00 £ 0.10	0 1.5	0.50 Illax.	U.UU IIIAX.	יווווו. אוווווי.

^{*} The values in the parentheses () are for reference.

CGA1, CGA2, CGA3, CGA4, CGA5, CGA6 (As for CGA6 type, any thickness of the item except 2.5mm)

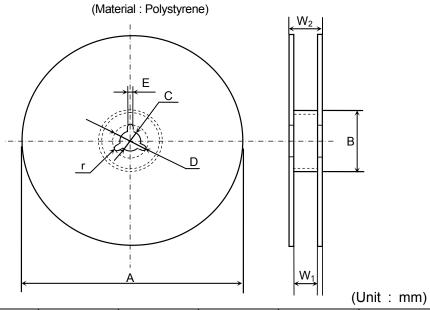


Symbol	А	В	С	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	r
Dimension	13.0 ± 1.4	1.0

Appendix 9

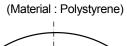
CGA6 (Applied to 2.5mm thickness products), CGA8, CGA9

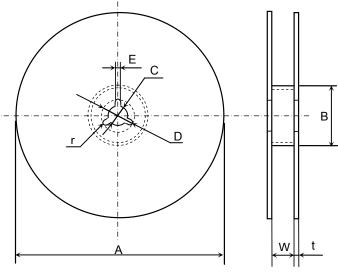


Symbol	Α	В	С	D	Е	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol	W_2	r
Dimension	17.0 ± 1.4	1.0

CGA1, CGA2, CGA3, CGA4, CGA5, CGA6 (As for CGA6 type, any thickness of the item except 2.5mm)





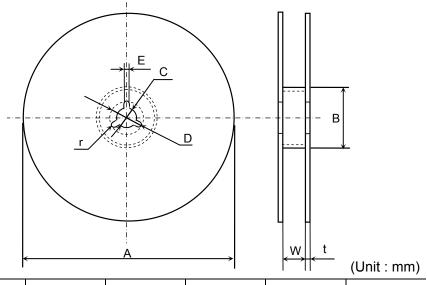
(Unit: mm)

Symbol	А	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

Appendix 11

CGA6 (Applied to 2.5mm thickness products), CGA8, CGA9 (Material : Polystyrene)



Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

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M39014/01-1467 M39014/02-1218V M39014/02-1225V M39014/02-1262V M39014/02-1301 M39014/22-0631 1210J5000102JCT

1210J2K00102KXT 1210J5000103KXT 1210J5000223KXT D55342E07B379BR-TR D55342E07B523DR-T/R 1812J1K00103KXT

1812J1K00473KXT 1812J2K00680JCT 1812J4K00102MXT 1812J5000102JCT 1812J5000103JCT 1812J5000682JCT NIN-FB391JTRF

NIN-FC2R7JTRF NPIS27H102MTRF C1206C101J1GAC C1608C0G1E472JT000N C2012C0G2A472J 2220J2K00101JCT

KHC201E225M76N0T00 LRC-LRF1206LF-01R025FTR1K 1812J1K00222JCT 1812J2K00102KXT 1812J2K00222KXT

1812J2K00472KXT 2-1622820-7-CUT-TAPE 2220J3K00102KXT 2225J2500824KXT CCR07CG103KM CGA2B2C0G1H010C

CGA2B2C0G1H040C CGA2B2C0G1H050C CGA2B2C0G1H060D CGA2B2C0G1H070D CGA2B2C0G1H151J CGA2B2C0G1H1R5C

CGA2B2C0G1H2R2C CGA2B2C0G1H3R3C CGA2B2C0G1H680J CGA2B2C0G1H6R8D CGA2B2X8R1H221K CGA2B2X8R1H472K

CGA3E1X7R1C474K